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Supplementary Information

Strain and Electric Field Modulated Electronic Structure of Two-dimensional

SiP(SiAs)/GeS van der Waals Heterostructures

Yingmei Zhu¹, Xiaocha Wang^{1,*}, Wenbo Mi²

¹Tianjin Key Laboratory of Film Electronic & Communicate Devices, School of Electrical and Electronic Engineering, Tianjin University of Technology, Tianjin 300384, China

²Tianjin Key Laboratory of Low Dimensional Materials Physics and Preparation Technology, School of Science, Tianjin University, Tianjin 300354, China

^{*}Author to whom all correspondence should be addressed.

E-mail: wangxc@email.tjut.edu.cn



Fig. S1. Top and side views of (a) model-I, (b) model-II, (c) model-III and (d) model-IV for SiAs/GeS heterostructures.